

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



## Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

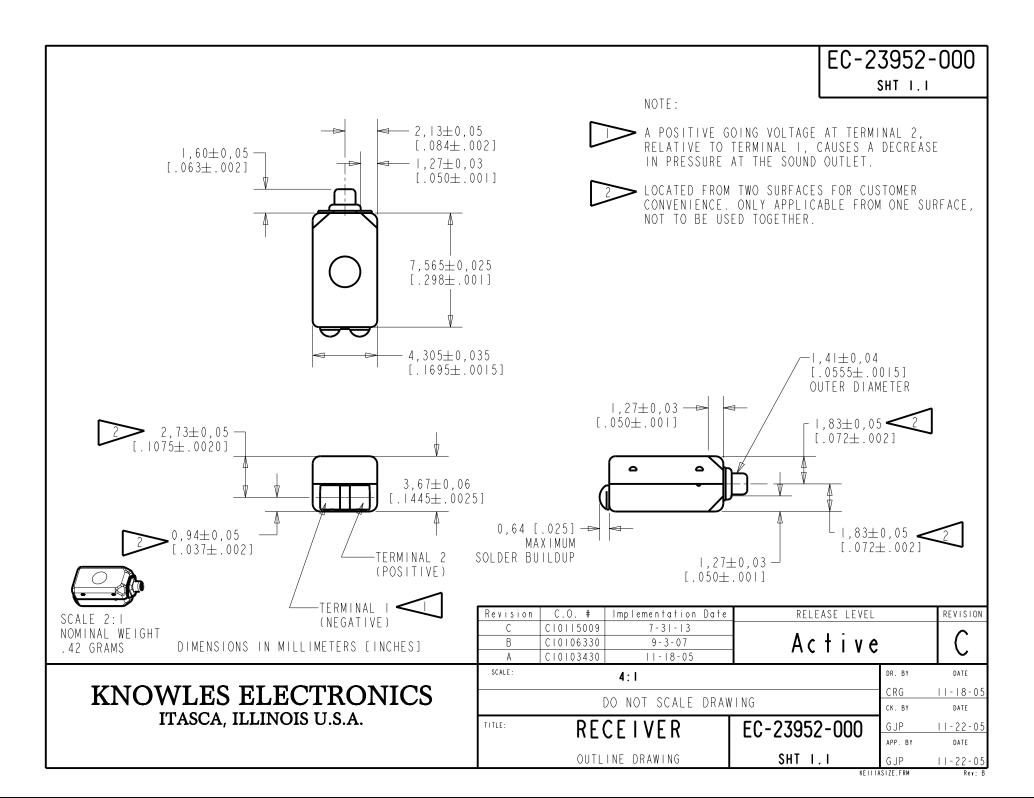
Email & Skype: info@chipsmall.com Web: www.chipsmall.com

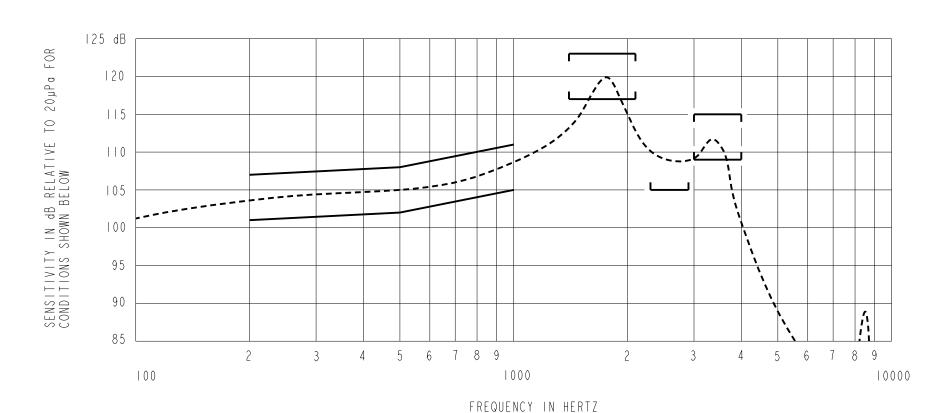
Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China











## NOTES:

- I. MEASUREMENTS MADE USING 10mm (.394") OF 1mm (.039") ID TUBE CONNECTED TO A SIMULATED ANSI S3.7 TYPE HA-3 COUPLER. (IEC 60318-5).
- 2. SENSITIVITY

FREQUENCY	<u>M   N .</u>	MAX.
200	101.0	107.0
500	102.0	108.0
1000	105.0	111.0
1400-2100	117.0	123.0
2300-2900	105.0	
3000-4000	109 0	115 0

- 3. RESPONSE, IMPEDANCE, AND DISTORTION MEASUREMENTS MADE USING THE ELECTRICAL TEST CONDITIONS SHOWN BELOW.
- 4. ELECTRICAL SOURCE IMPEDANCE MUST BE GREATER THAN 20 TIMES IKHZ IMPEDANCE FOR TEST CONDITIONS SHOWN BELOW.
- 5. INDIVIDUAL SPECIFICATIONS:

PORT LOCATION	IMPEDANCE OHMS ±15%		DCR @20°C	DISTORTION		ELECTRICAL TEST CONDITIONS	
	I K H z	500Hz	OHMS ±10%	MAX. %	FREQ Hz	AC mA RMS	DC mA
128	200	100	51	10	800	1.55	0.0

Revision	C.O. #	Implementation Date	RELEASE LEVEL		REVISION
С	C10115009	7 - 3   -   3			^
В	C10106330	9 - 3 - 07	l Active		(
А	C10103430	11-18-05			
			INSPECTION ACCEPTANCE/REJECTION	DR. BY	DATE

KNOWLES ELECTRONICS ITASCA, ILLINOIS U.S.A.

	AND TEST METHOD VARIATION	ON REQUIRED FOR	CRG ck. by
TITLE: RF	^FIVFR	FC-23952-000	GJP

PERFORMANCE SPECIFICATION

EC-23952-000	
20002 000	APF
SHT 2.1	G.

11-18-05

DATE

11-22-05

11-22-05